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1:1 14-bit SSTL\_2 Registered Buffer



ADE-205-336F (Z)

Rev.6 June. 2001

#### **Description**

The HD74SSTV16857 is a 14-bit registered buffer designed for 2.3 V to 2.7 V Vcc operation and LVCMOS reset ( $\overline{RESET}$ ) input / SSTL\_2 data (D) inputs and CLK input.

Data flow from D to Q is controlled by differential clock pins (CLK,  $\overline{\text{CLK}}$ ) and the  $\overline{\text{RESET}}$ . Data is triggered on the positive edge of the positive clock (CLK), and the negative clock ( $\overline{\text{CLK}}$ ) must be used to maintain noise margins. When  $\overline{\text{RESET}}$  is low, all registers are reset and all outputs are low.

To ensure defined outputs from the register before a stable clock has been supplied,  $\overline{RESET}$  must be held in the low state during power up.

#### **Features**

- Supports LVCMOS reset (RESET) input / SSTL\_2 data (D) inputs and CLK input
- Differential SSTL\_2 (Stub series terminated logic) CLK signal
- Flow through architecture optimizes PCB layout
- · Package type

Package type	Package code	Package suffix	Taping code
TSSOP-48 pin	TTP-48DB	Т	EL (1,000 pcs / Reel)
TVSOP-48 pin	TTP-48DEV	N	EL (1,000 pcs / Reel)

# **Function Table**

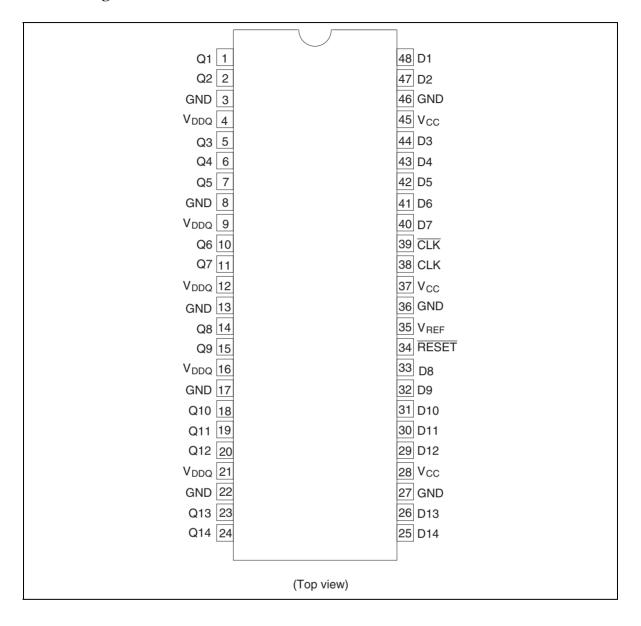
Inputs		Output Q		
RESET	CLK	CLK	D	
L	Х	Х	Х	L
Н	<b>\</b>	1	Н	Н
Н	<b>\</b>	1	L	L
Н	L or H	H or L	Х	Q <sub>0</sub> *1

H: High level
L: Low level
X: Immaterial

↑: Low to high transition ↓: High to low transition

Note: 1. Output level before the indicated steady state input conditions were established.

# **Pin Arrangement**



#### **Absolute Maximum Ratings**

Item	Symbol	Ratings	Unit	Conditions
Supply voltage	$V_{CC}$ or $V_{DDQ}$	-0.5 to 3.6	V	
Input voltage *1	V <sub>i</sub>	-0.5 to V <sub>DDQ</sub> +0.5	V	
Output voltage *1, 2	V <sub>o</sub>	-0.5 to V <sub>DDQ</sub> +0.5	V	
Input clamp current	I <sub>IK</sub>	±50	mA	$V_{l} < 0 \text{ or } V_{l} > V_{CC}$
Output clamp current	I <sub>ok</sub>	±50	mA	$V_{o} < 0 \text{ or } V_{o} > V_{DDQ}$
Continuous output current	I <sub>o</sub>	±50	mA	$V_{o} = 0$ to $V_{DDQ}$
$\overline{V_{\text{CC}}, V_{\text{DDQ}}}$ or GND current / pin	$I_{\rm CC}$ , $I_{\rm DDQ}$ or $I_{\rm GND}$	±100	mA	
Maximum power dissipation at Ta = 55°C (in still air)	P <sub>T</sub>	115	°C / W	TSSOP
Storage temperature	Tstg	-65 to +150	°C	

#### Notes:

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute maximum rated conditions for extended periods may affect device reliability.

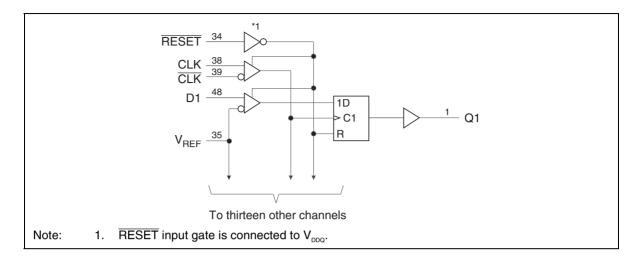
- 1. The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.
- 2. This current will flow only when the output is in the high state and  $V_0 > V_{ppo}$ .

# **Recommended Operating Conditions**

Item	Symbol	Min	Тур	Max	Unit	Conditions
Supply voltage	V <sub>cc</sub>	V <sub>DDQ</sub>	2.5	2.7	V	
Output supply voltage	$V_{\scriptscriptstyle DDQ}$	2.3	2.5	2.7	V	
Reference voltage	$V_{REF}$	1.15	1.25	1.35	V	$V_{\text{REF}} = 0.5 \times V_{\text{DDQ}}$
Termination voltage	$V_{TT}$	$V_{\text{\tiny REF}}$ –40 mV	$V_{REF}$	$V_{\text{\tiny REF}}$ +40 mV	V	
Input voltage	V <sub>i</sub>	0	_	V <sub>cc</sub>	V	<del>-</del>
AC high level input voltage	V <sub>IH</sub>	$V_{\text{REF}}$ +310 mV	_	_	V	D
AC low level input voltage	V <sub>IL</sub>	_	_	$V_{\text{REF}}$ –310 mV	V	D
DC high level input voltage	V <sub>IH</sub>	V <sub>REF</sub> +150 mV	_	_	V	D
DC low level input voltage	V <sub>IL</sub>	_	_	V <sub>REF</sub> -150 mV	V	D
High level input voltage	V <sub>IH</sub>	1.7	_	$V_{DDQ} + 0.3$	V	RESET
Low level input voltage	V <sub>IL</sub>	-0.3	_	0.7	V	RESET
Differential (Common mode range)	$V_{\scriptscriptstyle \sf CMR}$	0.97	_	1.53	V	CLK, CLK
input voltage (Minimum peak to peak input)	$V_{pp}$	360	_	_	mV	CLK, CLK
High level output current	I <sub>OH</sub>	_	_	-20	mΑ	
Low level output current	I <sub>OL</sub>	_		20	mΑ	
Operating temperature	Та	0	_	70	°C	

Note: The RESET input of the device must be held at V<sub>DDO</sub> or GND to ensure proper device operation. The differential inputs must not be floating, unless RESET is low.

# Logic Diagram



# **Electrical Characteristics**

Item	Symbol	$V_{cc}(V)$	Min	Тур	Max	Unit	Test Conditions
Input diode voltage	V <sub>IK</sub>	2.3	_	_	-1.2	٧	$I_{IN} = -18 \text{ mA}$
Output voltage	V <sub>OH</sub>	2.3 to 2.7	V <sub>cc</sub> -0.2	_	_	٧	I <sub>OH</sub> = -100 μA
		2.3	1.95	_	$V_{\scriptscriptstyle DDQ}$	=	I <sub>OH</sub> = −16 mA
	V <sub>OL</sub>	2.3 to 2.7	_	_	0.2	=	I <sub>oL</sub> = 100 μA
		2.3	0	_	0.35	=	I <sub>oL</sub> = 16 mA
Input current (All inputs)	I <sub>IN</sub>	2.7	_	_	±5	μΑ	V <sub>IN</sub> = 2.7 V or 0
Quiescent supply current	I <sub>CC</sub> *2	2.7	_	_	45	mA	$V_{IN} = V_{IH(AC)}$ or $V_{IL(AC)}$ , $I_{O} = 0$
Standby current	CC (stdy)	2.7	_	_	10	μΑ	RESET = GND
Dynamic operating clock only	CCD *2	2.7	_	_	90		$\label{eq:RESET} \hline \textbf{RESET} = \textbf{V}_{\text{CC}}, \\ \textbf{V}_{\text{I}} = \textbf{V}_{\text{IH}(\text{AC})} \text{ or } \textbf{V}_{\text{IL}(\text{AC})}, \\ \textbf{CLK and } \overline{\textbf{CLK}} \text{ switching 50\%} \\ \textbf{duty cycle} \\ \hline$
Dynamic operating per each data input	I <sub>CCD</sub> *2	2.7	_	_	15	clock MHz / data	$\label{eq:RESET} \hline \textbf{RESET} = \textbf{V}_{\text{CC}}, \\ \textbf{V}_{\text{I}} = \textbf{V}_{\text{IH}(\text{AC})} \text{ or } \textbf{V}_{\text{IL}(\text{AC})}, \\ \textbf{CLK and } \hline \textbf{CLK} \text{ switching } 50\% \\ \text{duty cycle. One data input switching at half clock} \\ \text{frequency, } 50\% \text{ duty cycle.} \\ \hline \\ \hline \end{tabular}$
Output high *3	r <sub>oh</sub>	2.3 to 2.7	7	_	22 *4	Ω	I <sub>OH</sub> = -20 mA
Output low *3	r <sub>oL</sub>	2.3 to 2.7	7	_	22 *4	Ω	I <sub>oL</sub> = 20 mA
r <sub>OH</sub> - r <sub>OL</sub>   each separate bit <sup>'3</sup>	$r_{_{O(\Delta)}}$	2.5	_	_	4	Ω	$I_o = 20$ mA, $Ta = 25$ °C
Input Data inputs	C <sub>IN</sub>	2.5 *1	2.5	_	3.5	pF	$V_{I} = V_{REF} \pm 310 \text{ mV}$
capacitance CLK and CLK	-		2.5	_	3.5	_	$V_{\text{CMR}} = 1.25 \text{ V}, V_{\text{pp}} = 360 \text{ mV}$
RESET	-		_	3.0	_	_	$V_{i} = V_{cc}$ or GND

Notes: 1. All typical values are at  $V_{cc} = 2.5 \text{ V}$ ,  $Ta = 25^{\circ}\text{C}$ .

- 2. Total  $I_{cc}$  (max) =  $I_{cc}$  + { $I_{ccd}$  (clock)×f(clock)} + { $I_{ccd}$  (Data)×1/2f(clock)×14}
- 3. This is effective in the case that it did terminate by resistance.
- 4. See figure. 1, 2

#### **Switching Characteristics**

Item		Symbol	$V_{cc}$ = 2.5 ± 0.2 V		Unit	Test Condition
			Min	Max	_	
Clock frequency *1		f <sub>clock</sub>	_	200	MHz	
Setup time	Fast slew rate *4,6	t <sub>su</sub>	0.75	_	ns	Data before CLK↑, CLK↓
	Slow slew rate *5, 6		0.9	_		
Hold time	Fast slew rate *4,6	t <sub>h</sub>	0.75	_	ns	Data after CLK↑, CLK↓
	Slow slew rate *5, 6	_	0.9	_	<del></del>	
Differential inputs active time		t <sub>act</sub>	22	_	ns	Data inputs must be low after RESET high.
Differential inputs inactive time		t <sub>inact</sub>	22		ns	Data and clock inputs must be held at valid levels (not floating) after RESET low.
Pulse width		t <sub>w</sub>	2.5	_	ns	CLK, CLK "H" or "L"
Output slew *3		t <sub>sl</sub>	1	4	volt/ns	

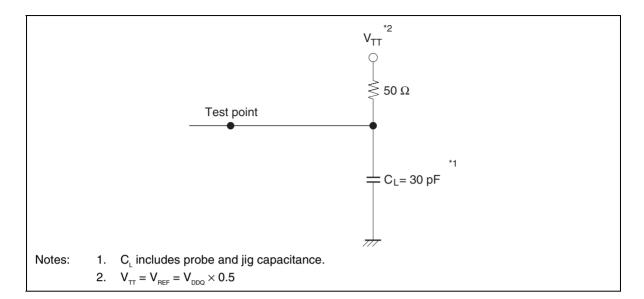
$$(C_L = 30 \text{ pF}, R_L = 50 \Omega, V_{REF} = V_{TT} = V_{DDQ} \times 0.5)$$

Item	Symbol	$V_{cc} = 2.5 \pm 0.2 V$			Unit	FROM	то
		Min	Тур	Max		(Input)	(Output)
Maximum clock frequency	f <sub>max</sub>	200	_	_	MHz		
Propagation delay time *2	t <sub>PLH,</sub> t <sub>PHL</sub>	1.1	_	2.8	ns	CLK, CLK	Q
	t <sub>PHL</sub>	_	_	5.0		RESET	Q

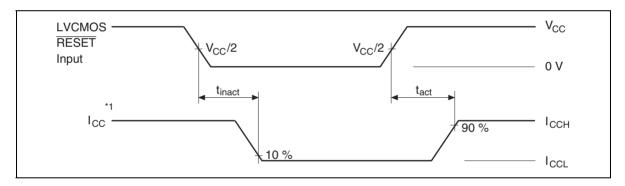
Notes: 1. Although the clock is differential, all timing is relative to CLK going high and CLK going low.

- 2. This timing relationship is specified into test load (see waveforms 3, 4) with all of the outputs switching.
- 3. Assumes into an equivalent, distributed load to the address net structure defined in the application information provided in this specification.
- 4. For data signal input slew rate  $\geq$  1 V/ns.
- 5. For data signal input slew rate  $\geq$  0.5 V/ns and < 1 V/ns.
- 6. CLK,  $\overline{\text{CLK}}$  signals input slew rates are  $\geq$  1 V/ns.

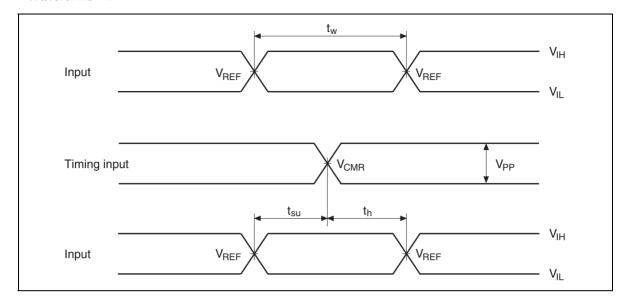
# **Test Circuit**



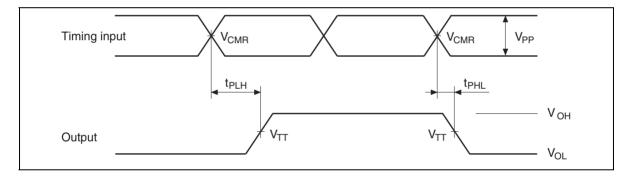
#### Waveforms - 1



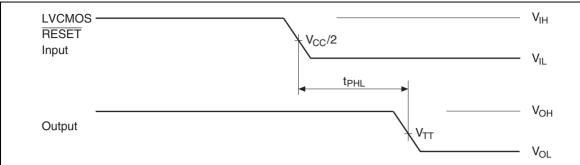
#### Waveforms - 2



#### Waveforms – 3



#### Waveforms - 4



Notes:

- 1.  $I_{cc}$  tested with clock and data inputs held at  $V_{cc}$  or GND, and  $I_{o}$  = 0 mA.
- 2. All input pulses are supplied by generators having the following characteristics : PRR  $\leq$  10 MHz, Zo = 50  $\Omega$ , input slew rate = 1 V/ns  $\pm$ 20% (unless otherwise specified).
- 3. The outputs are measured one at a time with one transition per measurement.
- 4.  $V_{TT} = V_{REF} = V_{DDQ}/2$
- 5.  $V_{IH} = V_{REF} + 310 \text{ mV}$  (AC voltage levels) for differential inputs.  $V_{IH} = V_{CC}$  for LVCMOS input.
- 6.  $V_{\parallel} = V_{BEF} 310 \text{ mV}$  (AC voltage levels) for differential inputs.  $V_{\parallel} = \text{GND}$  for LVCMOS input.
- 7.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$

# **Application Data**

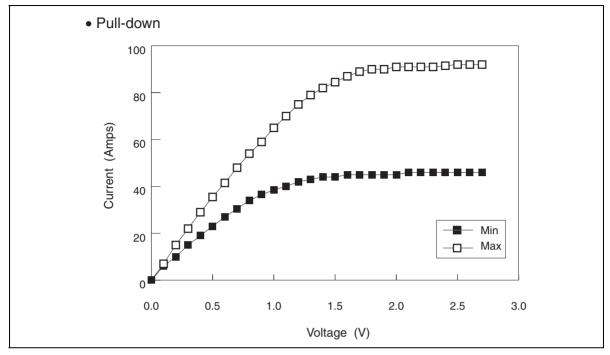


Figure . 1

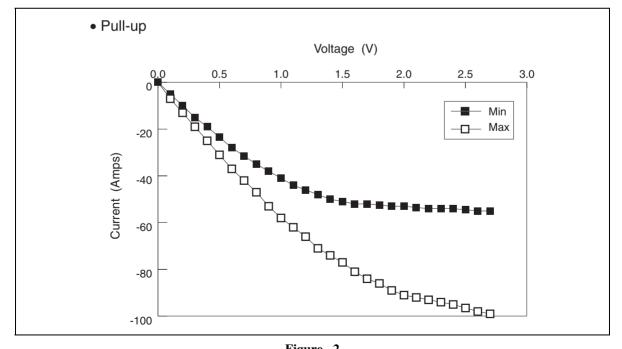
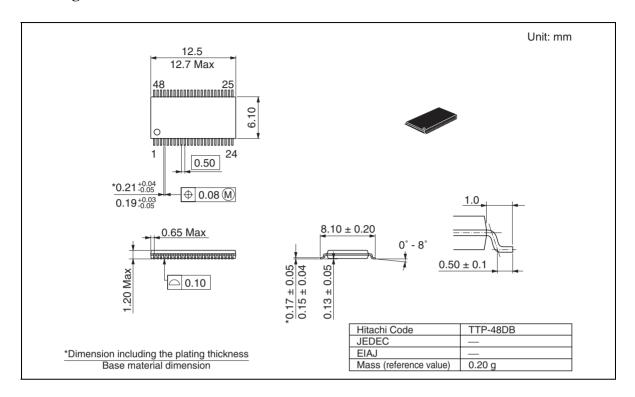


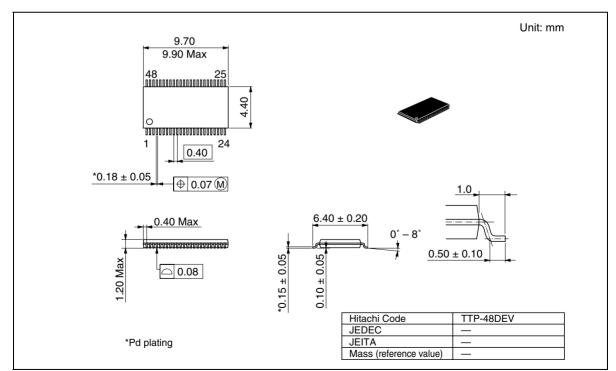
Figure . 2

# **Curve Data**

Voltage (V)	Pull-down		Pull-up	Pull-up			
	I (mA)	I (mA)	I (mA)	I (mA)			
	Min	Max	Min	Max			
0.0	0	0	0	0			
0.1	6	7	-5	<b>-</b> 7			
0.2	10	15	-10	-13			
0.3	15	22	-15	<b>–</b> 19			
0.4	19	29	-19	<b>–</b> 25			
0.5	23	35.5	-23.5	<del>-</del> 31			
0.6	27	41.5	-28	-37			
0.7	30.5	48	-31.5	-42			
0.8	34	54	-35	-47			
0.9	36.5	59	-38	<b>-</b> 53			
1.0	38.5	65	-41	<b>–</b> 58			
1.1	40	70	-44	-62			
1.2	42	75	-46	-66			
1.3	43	79	-48	<b>–</b> 71			
1.4	44	82	-50	-74			
1.5	44	84.5	<b>–</b> 51	<b>–</b> 77			
1.6	45	87	<b>-52</b>	-81			
1.7	45	89	-52	-84			
1.8	45	90	-52.5	-86			
1.9	45	90	-53	-89			
2.0	45	91	-53	<b>-</b> 91			
2.1	46	91	-53.5	-92			
2.2	46	91	-54	-93			
2.3	46	91	-54	-94			
2.4	46	91.5	-54	<b>-</b> 95			
2.5	46	92	-54.5	-96.5			
2.6	46	92	-55	-98			
2.7	46	92	-55	-99			

# **Package Dimensions**





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